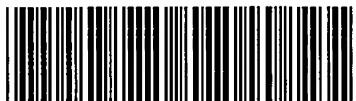


Search Notes

Application/Control No.

10/734,357

Examiner

David Mis

Applicant(s)/Patent under
Reexamination

DEVNATH ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
331	46, 48, 50, 52, 55, 108B,	6/20/2005	DM
	117R,		
	117FE,		
	117D,		
	135-137,		
	172,		
	177R,		
	177V		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
as	above	6/20/2005	DM